

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

Automotive grade HiCap

X7R

6.3 V TO 100 V

1 μ F to 10 μ F

RoHS compliant & Halogen Free



SCOPE

This specification describes Automotive grade X7R series chip capacitors with lead-free terminations and used for automotive equipments.

APPLICATIONS

All general purpose applications
Entertainment applications
Comfort / security applications
Information applications

FEATURES

- AEC-Q200 qualified
- MSL class: MSL I
- AC series soldering is compliant with J-STD-020D
- High component and equipment reliability
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AC xxxx x x xxx x **B** x xxx
(1) (2) (3) (4) (5) (6) (7)

(1) SIZE – INCH BASED (METRIC)

0201 (0603) / 0402 (1005) / 0603 (1608) / 0805 (2012) / 1206 (3216) / 1210 (3225) / 1812 (4532)

(2) TOLERANCE

J = ±5%
K = ±10%
M = ±20%

Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales before order

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch
K = Blister taping reel; Reel 7 inch
P = Paper/PE taping reel; Reel 13 inch
F = Blister taping reel; Reel 13 inch

(4) TC MATERIAL

X7R

(5) RATED VOLTAGE

4 = 4 V
5 = 6.3 V
6 = 10 V
7 = 16 V
8 = 25 V
G = 35 V
9 = 50 V
0 = 100 V

(6) PROCESS

B = X7R

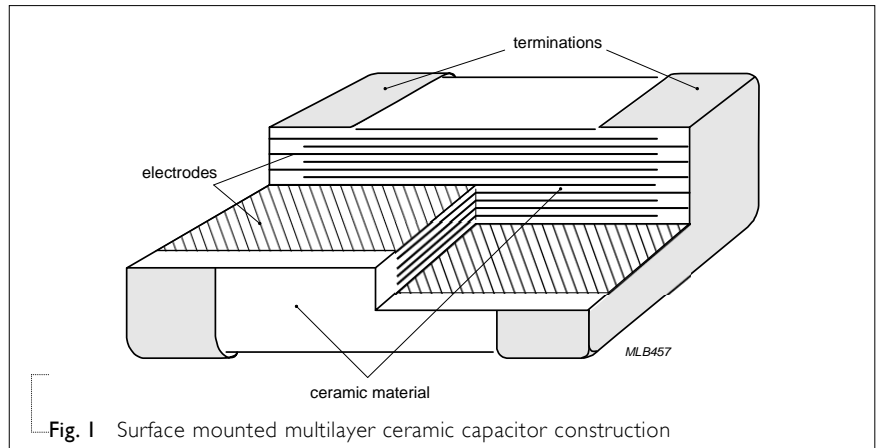
(7) CAPACITANCE VALUE

2 significant digits + number of zeros
The 3rd digit signifies the multiplying factor, and letter R is decimal point
Example: 121 = 12 × 10¹ = 120 pF

CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are lead-free. A cross section of the structure is shown in Fig.1.

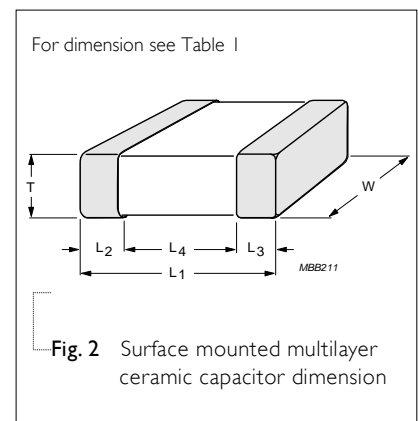


DIMENSION

Table I For outlines see fig. 2

TYPE	L ₁ (mm)	W (mm)	T (MM)	L ₂ / L ₃ (mm)		L ₄ (mm)
				min.	max.	min.
0201	0.6 ±0.03	0.3±0.03	0.3±0.03	0.10	0.20	0.20
0402	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15	0.35	0.40
0603	1.6 ±0.10	0.8 ±0.10	0.8 ±0.10	0.20	0.60	0.40
0805	2.0 ±0.10	1.25 ±0.10	0.6 ±0.10	0.25	0.75	0.70
			0.85 ±0.10			
	2.0 ±0.20	1.25 ±0.20	1.25 ±0.20			
	3.2 ±0.15	1.6 ±0.15	0.6 ±0.10			
			0.85 ±0.10			
1206	3.2 ±0.30	1.6 ±0.20	1.15 ± 0.10	0.25	0.75	1.40
			1.25 ±0.20			
	3.2 ±0.30	1.6 ±0.30	1.6 ±0.20			
			1.6 ±0.30			
	3.2 ±0.20	2.5 ±0.20	0.85 ±0.10			
			1.25 ±0.20			
1210	3.2 ±0.30	2.5 ±0.20	1.6 ±0.20	0.25	0.75	1.40
			2.0 ±0.20			
	3.2 ±0.40	2.5 ±0.30	2.5 ±0.20			
1808	4.5 ±0.40	2.0 ±0.30	1.25 ±0.20	0.25	0.75	2.20
1812	4.5 ±0.40	3.2 ±0.30	0.85 ±0.10	0.25	0.75	2.20
			1.25 ±0.20			
			1.6 ±0.20			

OUTLINES



CAPACITANCE RANGE & THICKNESS FOR X7R

Table 2 Sizes from 0603 to 0805

CAP.	0603				0805					
	6.3V	10V	16 V	25 V	6.3 V	10 V	16 V	25 V	35 V	50 V
1 µF	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1		1.25±0.2	1.25±0.2	1.25±0.2		1.25±0.2
2.2 µF						1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	
4.7 µF						1.25±0.2	1.25±0.2			
10 µF					1.25±0.2					

Table 3 Sizes 1206

CAP.	1206					
	6.3 V	10V	16V	25V	50 V	100 V
1 µF		1.15±0.10	1.15±0.10	1.60±0.2	1.60±0.2	1.60±0.2
2.2 µF			1.60±0.2	1.60±0.2	1.60±0.2	1.60±0.2
4.7 µF	1.60±0.2	1.60±0.2	1.60±0.2			
10 µF						

Table 4 Sizes 1210 to 1812

CAP.	1210			1812	
	25 V	50V	100 V	50V	100V
1 µF	1.25±0.20	1.25±0.20	2.0±0.2	1.60±0.2	1.60±0.2
2.2 µF		2.0±0.2	2.0±0.2		
4.7 µF	2.5±0.2	2.5±0.2			

NOTE

1. Values in shaded cells indicate thickness class in mm
2. Capacitance value of non E-6 series is on request

THICKNESS CLASSES AND PACKING QUANTITY

Table 5

SIZE CODE	THICKNESS CLASSIFICATION	PACKING CODE		TAPE WIDTH	QUANTITY PER REEL			
		7 INCH	13 INCH		Ø180 MM / 7 INCH		Ø330 MM / 13 INCH	
					Paper	Blister	Paper	Blister
0201	0.3 ±0.03 mm	R	P	8 mm	15,000	---	50,000	---
0402	0.5 ±0.05 mm	R	P	8 mm	10,000	---	50,000	---
0603	0.8 ±0.1 mm	R	P	8 mm	4,000	---	15,000	---
0805	0.6 ±0.1 mm	R	P	8 mm	4,000	---	20,000	---
	0.85 ±0.1 mm	R	P	8 mm	4,000	---	15,000	---
	1.25 ±0.2 mm	K	F	8 mm	---	3,000	---	10,000
1206	0.6 ±0.1 mm	R	P	8 mm	4,000	---	20,000	---
	0.85 ±0.1 mm	R	P	8 mm	4,000	---	15,000	---
	1.0/1.15 ±0.1 mm	K	F	8 mm	---	3,000	---	10,000
	1.25 ±0.2 mm	K	F	8 mm	---	3,000	---	10,000
1210	0.85 ±0.1 mm	K	F	8 mm	---	4,000	---	10,000
	1.15 ±0.1 mm	K	F	8 mm	---	3,000	---	10,000
	1.25 ±0.2 mm	K	F	8 mm	---	3,000	---	10,000
	2.0 ±0.2 mm	K		8 mm	---	2,000	---	---
	2.5 ±0.2 mm	K		8 mm	---	1,000	---	---
1812	0.6 / 0.85 ±0.1 mm	K		12 mm	---	2,000	---	---
	1.15 ±0.1 mm	K		12 mm	---	1,000	---	---
	1.25 ±0.2 mm	K		12 mm	---	1,000	---	---
	1.6 ±0.2 mm	K		12 mm	---	2,000	---	---

PAPER/PE TAPE SPECIFICATION

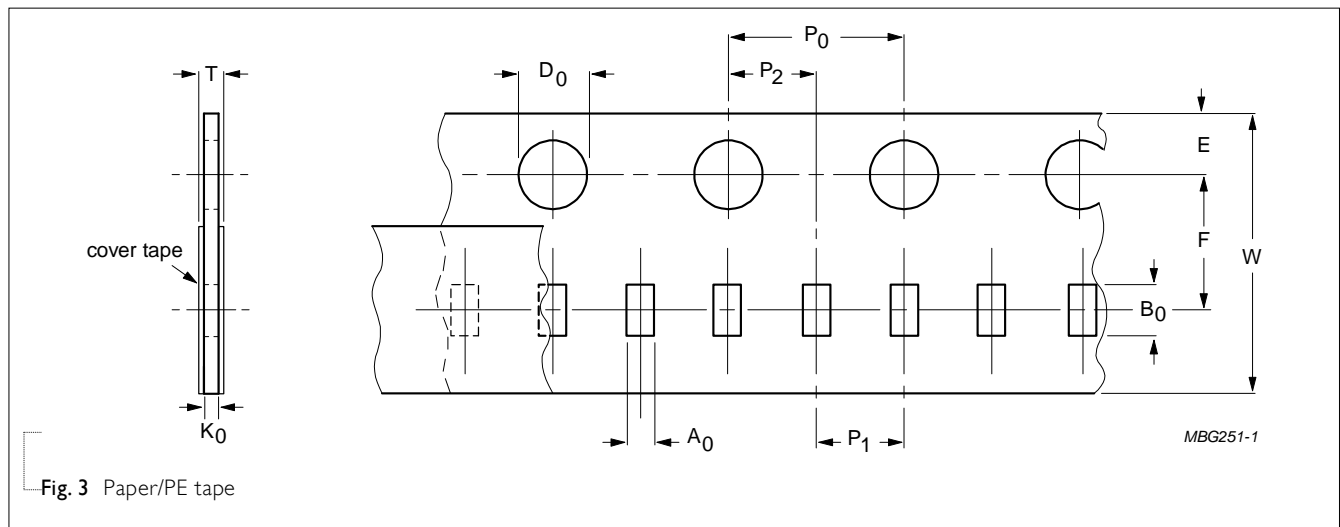


Fig. 3 Paper/PE tape

Table 6 Dimensions of paper/PE tape for relevant chip size; see Fig.3

SIZE	SYMBOL											Unit: mm
CODE	A ₀	B ₀	W	E	F	P ₀ ⁽¹⁾	P ₁	P ₂	ØD ₀	K ₀	T	
0201	0.39 ± 0.06	0.70 ± 0.06	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.55 ± 0.03	0.38 ± 0.05	(0.47 / 0.55)±0.10	
0402	0.70 ± 0.15	1.21 ± 0.12	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.50 +0.1 / -0	(0.75 / 0.60)±0.10	(0.85 / 0.70)±0.10	
0603	1.05 ± 0.14	1.86 ± 0.13	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 / -0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10	
0805	1.50 ± 0.15	2.26 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 / -0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10	
1206	1.90 ± 0.15	3.50 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 / -0	(0.95 / 0.75)±0.10	(1.05 / 0.85)± 0.10	

NOTE

1. P₀ pitch tolerance over any 10 pitches is ±0.2 mm

BLISTER TAPE SPECIFICATION

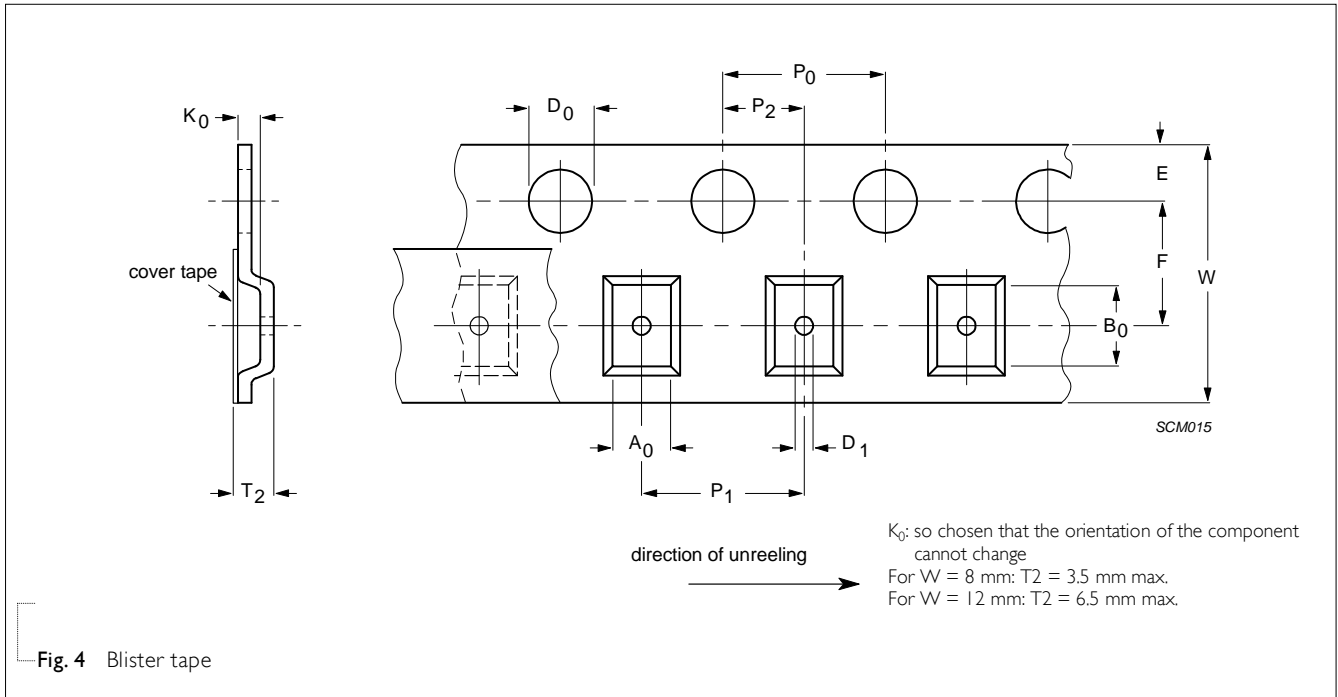


Fig. 4 Blister tape

Table 7 Dimensions of blister tape for relevant chip size; see Fig.4

SIZE CODE	SYMBOL												Unit: mm			
	A ₀		B ₀		K ₀		W	E	F	ØD ₀	ØD ₁	P ₀ ⁽²⁾	P ₁	P ₂	T ₂	
	Min.	Max.	Min.	Max.	Min.	Max.					Min.				Min.	Max.
0805	1.29	1.65	2.09	2.60	1.25	1.62	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.30	1.67
1206	1.65	2.12	3.30	3.75	1.22	2.15	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.27	2.20
1210	2.55	3.02	3.31	3.88	0.97	2.92	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.02	2.97
1808	2.05	2.55	4.80	5.45	1.30	2.45	12.1 ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.35	2.50
1812	3.35	3.75	4.70	5.33	0.70	2.40	12.1 ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	8.0 ±0.10	2.0 ±0.05	0.75	2.45

NOTE

1. Typical capacitor displacement in pocket
2. P₀ pitch tolerance over any 10 pitches is ±0.2 mm

REEL SPECIFICATION

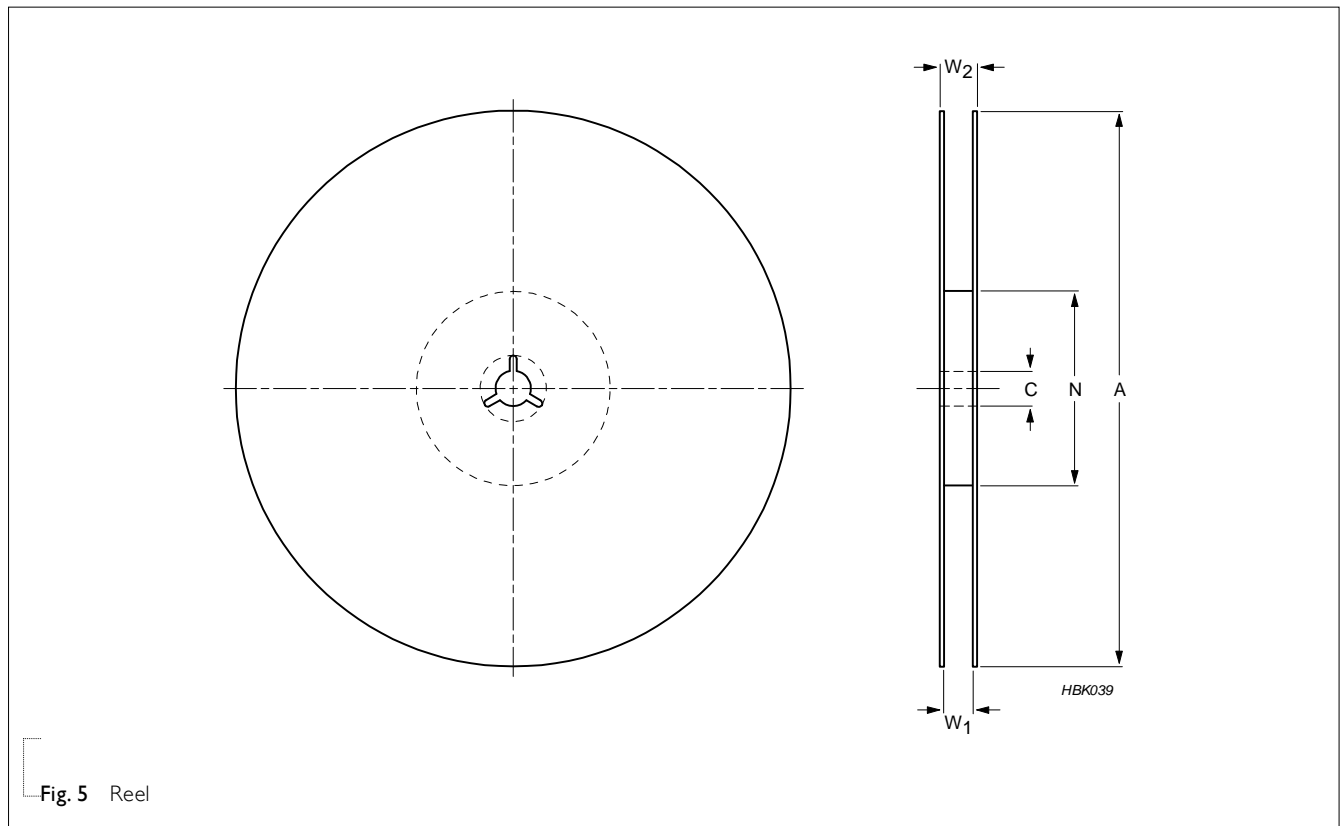


Fig. 5 Reel

Table 8 Reel dimensions; see Fig.5

TAPE WIDTH	SYMBOL			Unit: mm	
	A	N	C	W ₁	W _{2max.}
8 (Ø178 mm/7")	178 ±1.0	60 ±1.0	13 +0.50/-0.20	9.4 ±1.5	14.4
8 (Ø330 mm/13")	330 ±1.0	100 ±1.0	13 +0.50/-0.20	9.0 ±0.2	14.4
12 (Ø178 mm/7")	178 ±1.0	60 ±1.0	13 +0.50/-0.20	13.4 ±1.5	18.4

PROPERTIES OF REEL

Material: polystyrene

Surface resistance: 10^{10} Ω /sq.

ELECTRICAL CHARACTERISTICS

X7R DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C
- Relative humidity: 25% to 75%
- Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

DESCRIPTION	VALUE
Table 9	
Capacitance tolerance X7R	±5% ⁽¹⁾ , ±10%, ±20%
Maximum capacitance change as a function of temperature (temperature characteristic/coefficient): X7R	±15%
Operating temperature range: X7R	-55 °C to +125 °C

NOTE

1. Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales force before order

RATED VOLTAGE AND CAPACITANCE

Table 10

SIZE CODE	RATED VOLTAGE (V)	CAPACITANCE (μF)	D.F.	RC @ 25 °C (Ω · F)	RC @ 125 °C (Ω · F)
0603	6.3	1.0	5.0%	500	50
	10	1.0	5.0%	500	50
	16	1.0	5.0%	100	5
	25	1.0	5.0%	100	5
0805	10	1.0	5.0%	500	50
	16	1.0	5.0%	500	50
	25	1.0	5.0%	500	50
	50	1.0	5.0%	500	10
	10	2.2	5.0%	100	10
	16	2.2	5.0%	500	50
	25	2.2	5.0%	500	50
	35	2.2	5.0%	500	50
	10	4.7	10.0%	100	10
	16	4.7	10.0%	100	10
1206	6.3	10.0	10.0%	100	10
	10	1.0	3.5%	500	10
	25	1.0	3.5%	500	10
	50	1.0	5.0%	500	10
	100	1.0	5.0%	500	10
	16	2.2	5.0%	500	50
	25	2.2	5.0%	500	50
	50	2.2	5.0%	500	10
	100	2.2	5.0%	500	10
	6.3	4.7	10.0%	50	5
1210	10	4.7	10.0%	50	5
	16	4.7	10.0%	50	5
	25	1.0	2.5%	500	50
	50	1.0	2.5%	500	50
	100	1.0	5.0%	500	50
	50	2.2	5.0%	500	50
	100	2.2	5.0%	500	50
1812	25	4.7	10.0%	500	10
	50	4.7	10.0%	500	10
	50	1.0	2.5%	500	50
	100	1.0	2.5%	500	50

SOLDERING RECOMMENDATION

Table 11

SOLDERING METHOD	SIZE 0402	0603	0805	1206	≥ 1210
Reflow	≥ 0.1 μF	≥ 1.0 μF	≥ 2.2 μF	≥ 4.7 μF	Reflow only
Reflow/Wave	< 0.1 μF	< 1.0 μF	< 2.2 μF	< 4.7 μF	---

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202G-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 260 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

TESTS AND REQUIREMENTS

Table 12 Test procedures and requirements

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
Mounting	IEC 60384-21/22 4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage
Capacitance	IEC 60384-21/22 4.5.1	At 20 °C, 24 hours after annealing f = 1 KHz, measuring at voltage V _{rms} at 20 °C	Within specified tolerance
Dissipation Factor (D.F.)	IEC 60384-21/22 4.5.2	At 20 °C, 24 hours after annealing f = 1 KHz, measuring at voltage V _{rms} at 20 °C	In accordance with specification on table 10
Insulation Resistance	IEC 60384-21/22 4.5.3	At U _r (DC) for 1 minute	In accordance with specification on table 10

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS												
Temperature coefficient	4.6	<p>Capacitance shall be measured by the steps shown in the following table.</p> <p>The capacitance change should be measured after 5 min at each specified temperature stage.</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> </tr> </thead> <tbody> <tr> <td>a</td> <td>25±2</td> </tr> <tr> <td>b</td> <td>Lower temperature±3°C</td> </tr> <tr> <td>c</td> <td>25±2</td> </tr> <tr> <td>d</td> <td>Upper Temperature±2°C</td> </tr> <tr> <td>e</td> <td>25±2</td> </tr> </tbody> </table> <p>Class II</p> <p>Capacitance Change shall be calculated from the formula as below</p> $\Delta C = \frac{C2 - C1}{C1} \times 100\%$ <p>C1: Capacitance at step c C2: Capacitance at step b or d</p>	Step	Temperature(°C)	a	25±2	b	Lower temperature±3°C	c	25±2	d	Upper Temperature±2°C	e	25±2	ΔC/C: ±15%
Step	Temperature(°C)														
a	25±2														
b	Lower temperature±3°C														
c	25±2														
d	Upper Temperature±2°C														
e	25±2														
High Temperature Exposure	AEC-Q200 3	<p>Unpowered ; 1000hours @ T=150°C</p> <p>Measurement at 24±2 hours after test conclusion.</p>	<p>No visual damage</p> <p>ΔC/C :</p> <p>±10%</p> <p>D.F.:</p> <p>within initial specified value</p> <p>IR:</p> <p>within initial specified value</p>												
Temperature Cycling	AEC-Q200 4	<p>Preconditioning:</p> <p>150 +0/-10 °C for 1 hour, then keep for 24 ±1 hours at room temperature</p> <p>1000 cycles with following detail:</p> <p>30 minutes at lower category temperature</p> <p>30 minutes at upper category temperature</p> <p>Recovery time 24 ±2 hours</p>	<p>No visual damage</p> <hr/> <p>ΔC/C</p> <hr/> <p>±10%</p> <hr/> <p>D.F. meet initial specified value</p> <p>IR meet initial specified value</p>												
Destructive Physical Analysis	AEC-Q200 5	<p>Only applies to SMD ceramics.</p> <p>Electrical test not required.</p>													

Moisture Resistance

AEC-Q200 6

T=24 hrs/per cycle; 10 continuous cycles unpowered.
Measurement at 24 ±2 hours after test condition.

No visual damage

ΔC/C
±15%

D.F.
Within initial specified value
IR
Meet initial specified value

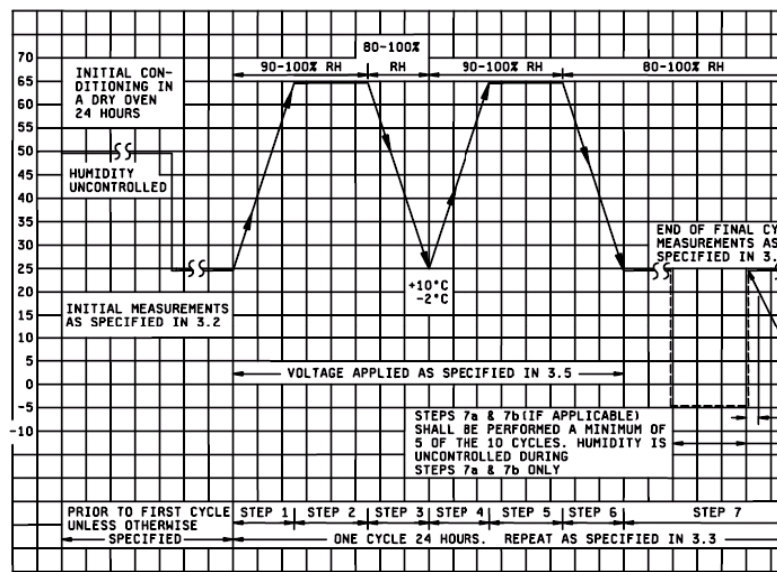


Fig. 6 Moisture resistant

Biased Humidity AEC-Q200 7

1. Preconditioning, class 2 only:
150 +0/-10 °C /1 hour, then keep for
24 ±1 hour at room temp
2. Initial measure:
Parameter: IR
Measuring voltage: 1.5V ± 0.1 VDC
Note: Series with 100 KΩ & 6.8 KΩ
3. Test condition:
85 °C, 85% R.H. connected with 100 KΩ resistor, applied
1.5V/U_r for 1,000 hours.
4. Recovery:
24 ±2 hours
5. Final measure: IR

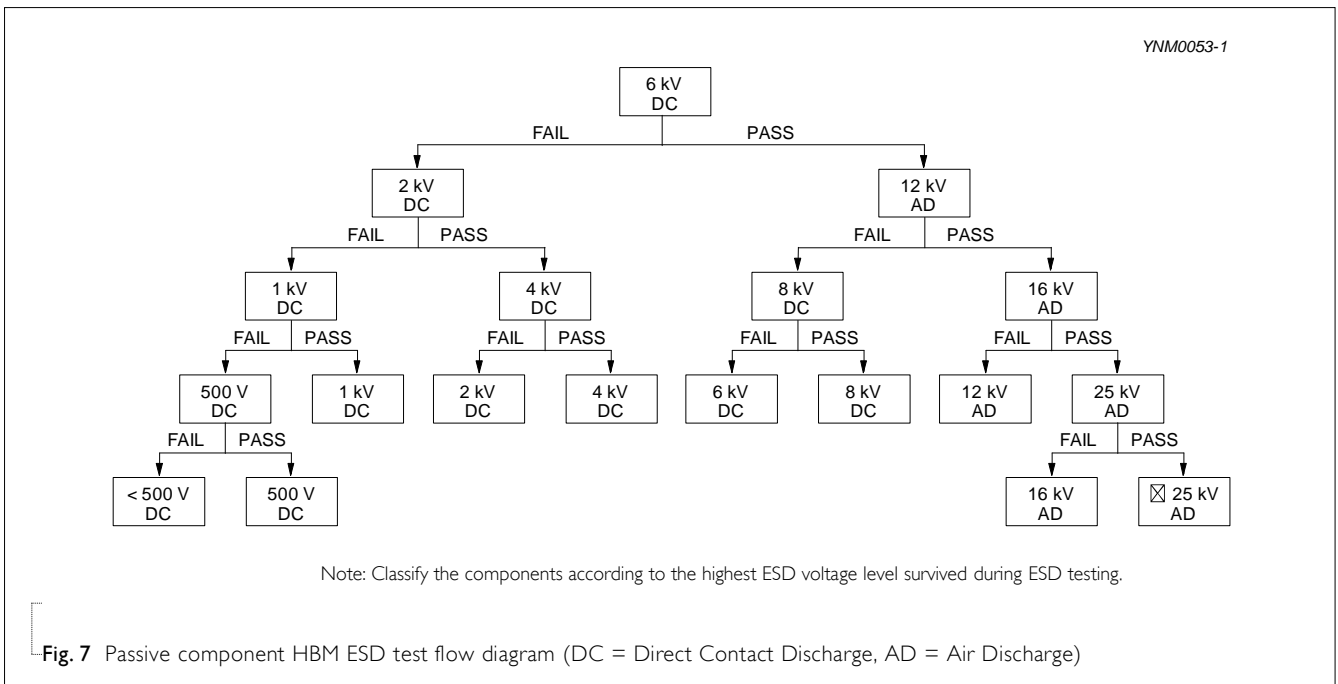
No visual damage after
recovery

Initial requirement:
- Connected to 100 KΩ:
C ≤ 25 nF: IR ≥ 4,000 MΩ or
C > 25 nF: (IR-100 KΩ) × C
≥ 100s.

Final measurement:
The insulation resistance shall
be greater than 10% of initial
spec.

Operational Life	AEC-Q200	8	1. Preconditioning: 150 +0/-10 °C /1 hour, then keep for 24 ±1 hour at room temp	No visual damage
			2. Initial measure: Spec: refer to initial spec C, D, IR	$\Delta C/C$ ±15%
			3. Endurance test: Temperature: X7R: 125 °C Specified stress voltage applied for 1,000 hours: Applied 150% U_r	Less than 200% of initial spec. IR
			4. Recovery time: 24 ±2 hours	The insulation resistance shall be greater than 10% of initial spec..
			5. Final measure: C, D, IR	
<p>Note: If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirement shall be met.</p>				
External Visual	AEC-Q200	9	Any applicable method using × 10 magnification	In accordance with specification
Physical Dimension	AEC-Q200	10	Verify physical dimensions to the applicable device specification.	In accordance with specification
Mechanical Shock	AEC-Q200	13	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500 g's	$\Delta C/C$ ±10%
			Duration: 0.5 ms Velocity change: 15.4 ft/s Waveform: Half-sin	D.F. Within initial specified value IR Within initial specified value
Vibration	AEC-Q200	14	5 g's for 20 minutes, 12 cycles each of 3 orientations. Note: Use 8" × 5" PCB, 0.31" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz.	$\Delta C/C$ ±10% D.F: meet initial specified value IR meet initial specified value

Resistance to Soldering Heat	AEC-Q200 15	<p>Precondition: 150 +0/-10 °C for 1 hour, then keep for 24 ± 1 hours at room temperature</p> <p>Preheating: for size ≤ I206: 120 °C to 150 °C for 1 minute</p> <p>Preheating: for size > I206: 100 °C to 120 °C for 1 minute and 170 °C to 200 °C for 1 minute</p> <p>Solder bath temperature: 260 ± 5 °C</p> <p>Dipping time: 10 ± 0.5 seconds</p> <p>Recovery time: 24 ± 2 hours</p>	<p>Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned</p> <hr/> <p>ΔC/C ± 10%</p> <hr/> <p>D.F. within initial specified value</p> <p>IR within initial specified value</p>
Thermal Shock	AEC-Q200 16	<ol style="list-style-type: none"> 1. Preconditioning: 150 +0/-10 °C / 1 hour, then keep for 24 ± 1 hour at room temp 2. Initial measure: Spec: refer to initial spec C, D, IR 3. Rapid change of temperature test: X7R: -55 °C to +125 °C; 300 cycles 15 minutes at lower category temperature; 15 minutes at upper category temperature. 4. Recovery time: X7R: 24 ± 2 hours 5. Final measure: C, D, IR 	<p>No visual damage</p> <hr/> <p>ΔC/C 15%</p> <hr/> <p>D.F. meet initial specified value</p> <p>IR meet initial specified value</p>
ESD	AEC-Q200 17	Per AEC-Q200-002	<p>A component passes a voltage level if all components stressed at that voltage level pass.</p>

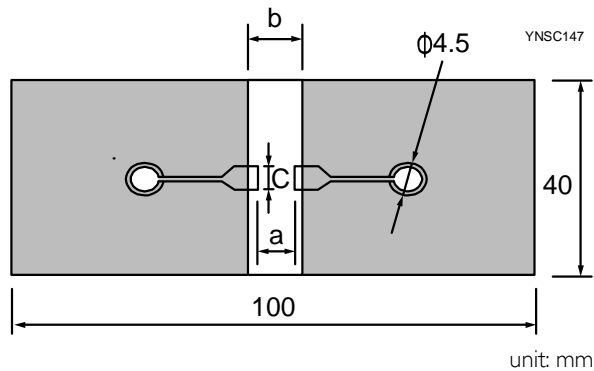


Solderability	AEC-Q200	18	Preheated to a temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination.
			<p>Test conditions for lead containing solder alloy</p> <p>Temperature: 235 ±5 °C Dipping time: 2 ±0.2 seconds Depth of immersion: 10 mm Alloy Composition: 60/40 Sn/Pb Number of immersions: 1</p> <p>Test conditions for lead-free containing solder alloy</p> <p>Temperature: 245 ±5 °C Dipping time: 3 ±0.3 seconds Depth of immersion: 10 mm Alloy Composition: SAC305 Number of immersions: 1</p>	

Electrical Characterization	AEC-Q200	19	Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures.	$\Delta C/C$ ±15%
			<p>X7R: -55 °C to +125 °C Normal temperature: 20 °C</p>	

Board Flex	AEC-Q200	21	Part mounted on a 100 mm X 40 mm FR4 PCB board, which is 1.6 ±0.2 mm thick and has a layer-thickness 35 µm ± 10 µm.	No visible damage
			<p>Part should be mounted using the following soldering reflow profile.</p> <p>Conditions: Bending 2 mm at a rate of 1 mm/s, radius jig 340 mm</p>	

Test Substrate:



Type	Dimension(mm)		
	a	b	c
0201	0.3	0.9	0.3
0402	0.4	1.5	0.5
0603	1.0	3.0	1.2
0805	1.2	4.0	1.65
1206	2.2	5.0	1.65
1210	2.2	5.0	2.0
1808	3.5	7.0	3.7

Terminal Strength	AEC-Q200 22	<p>With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested.</p> <p>This force shall be applied for 60+1 seconds.</p> <p>Also the force shall be applied gradually as not to apply a shock to the component being tested.</p> <p>* Apply 2N force for 0402 size.</p>	<p>Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body, terminals and body/terminal junction.</p> <p>Before, during and after the test, the device shall comply with all electrical requirements stated in this specification.</p>
Beam Load Test	AEC-Q200 23	<p>Place the part in the beam load fixture. Apply a force until the part breaks or the minimum acceptable force level required in the user specification(s) is attained.</p>	<p>≤ 0805</p> <p>Thickness > 0.5mm: 20N</p> <p>Thickness ≤ 0.5mm: 8N</p> <p>≥ 1206</p> <p>Thickness ≥ 1.25 mm: 54N</p> <p>Thickness < 1.25 mm: 15N</p>
Voltage Proof		<ol style="list-style-type: none"> 1. Specified stress voltage applied for 1~5 seconds 2. $U_r \leq 100 V$: series applied 2.5 U_r <p>Charge/Discharge current is less than 50 mA</p>	<p>No breakdown or flashover</p>

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
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Version 0	Feb. 25, 2021	-	- New
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